

# Search Notes



Application/Control No.

10/631,812

Examiner

Hoai V. Ho

Applicant(s)/Patent under Reexamination

TAKAHASHI ET AL.

Art Unit

2827

## SEARCHED

Class	Subclass	Date	Examiner
365	185.29 185.03 185.28	4/9/05	BW

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	185.29 185.03 185.28	4/9/05	BW

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR